

# SIGC41T120R3L

## IGBT<sup>3</sup> Chip

### FEATURES:

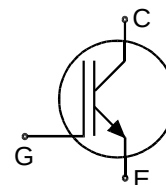
- 1200V Trench + Field Stop technology
- 120µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

### This chip is used for:

- power module

### Applications:

- drives



| Chip Type     | V <sub>CE</sub> | I <sub>CN</sub> | Die Size                   | Package      | Ordering Code     |
|---------------|-----------------|-----------------|----------------------------|--------------|-------------------|
| SIGC41T120R3L | 1200V           | 35A             | 6.5 x 6.37 mm <sup>2</sup> | sawn on foil | Q67050-A4207-A101 |

### MECHANICAL PARAMETER:

|                                       |                                                                                              |                 |
|---------------------------------------|----------------------------------------------------------------------------------------------|-----------------|
| Raster size                           | 6.5 x 6.37                                                                                   | mm              |
| Emitter pad size ( include gate pad ) | 4.99 x 4.89                                                                                  |                 |
| Gate pad size                         | 1.14 x 1.14                                                                                  |                 |
| Area total / active                   | 41.4 / 30.1                                                                                  | mm <sup>2</sup> |
| Thickness                             | 120                                                                                          | µm              |
| Wafer size                            | 150                                                                                          | mm              |
| Flat position                         | 180                                                                                          | grd             |
| Max.possible chips per wafer          | 350 pcs                                                                                      |                 |
| Passivation frontside                 | Photoimide                                                                                   |                 |
| Emitter metallization                 | 3200 nm Al Si 1%                                                                             |                 |
| Collector metallization               | 1400 nm Ni Ag –system<br>suitable for epoxy and soft solder die bonding                      |                 |
| Die bond                              | electrically conductive glue or solder                                                       |                 |
| Wire bond                             | Al, <500µm                                                                                   |                 |
| Reject Ink Dot Size                   | Ø 0.65mm ; max 1.2mm                                                                         |                 |
| Recommended Storage Environment       | store in original container, in dry nitrogen,<br>< 6 month at an ambient temperature of 23°C |                 |

**MAXIMUM RATINGS:**

| Parameter                                             | Symbol         | Value        | Unit |
|-------------------------------------------------------|----------------|--------------|------|
| Collector-emitter voltage                             | $V_{CE}$       | 1200         | V    |
| DC collector current, limited by $T_{jmax}$           | $I_C$          | 35           | A    |
| Pulsed collector current, $t_p$ limited by $T_{jmax}$ | $I_{Cpuls}$    | 70           | A    |
| Gate emitter voltage                                  | $V_{GE}$       | $\pm 20$     | V    |
| Operating junction and storage temperature            | $T_j, T_{stg}$ | -55 ... +150 | °C   |

**STATIC CHARACTERISTICS (tested on chip),  $T_j=25^\circ\text{C}$ , unless otherwise specified:**

| Parameter                            | Symbol        | Conditions                 | Value |      |      | Unit     |
|--------------------------------------|---------------|----------------------------|-------|------|------|----------|
|                                      |               |                            | min.  | typ. | max. |          |
| Collector-emitter breakdown voltage  | $V_{(BR)CES}$ | $V_{GE}=0V, I_C=1.5mA$     | 1200  |      |      | V        |
| Collector-emitter saturation voltage | $V_{CE(sat)}$ | $V_{GE}=15V, I_C=35A$      | 1.35  | 1.65 | 2.05 |          |
| Gate-emitter threshold voltage       | $V_{GE(th)}$  | $I_C=1.5mA, V_{GE}=V_{CE}$ | 5.0   | 5.8  | 6.5  |          |
| Zero gate voltage collector current  | $I_{CES}$     | $V_{CE}=1200V, V_{GE}=0V$  |       |      | 250  | $\mu A$  |
| Gate-emitter leakage current         | $I_{GES}$     | $V_{CE}=0V, V_{GE}=30V$    |       |      | 600  | nA       |
| Integrated gate resistor             | $R_{Gint}$    |                            |       | 6    |      | $\Omega$ |

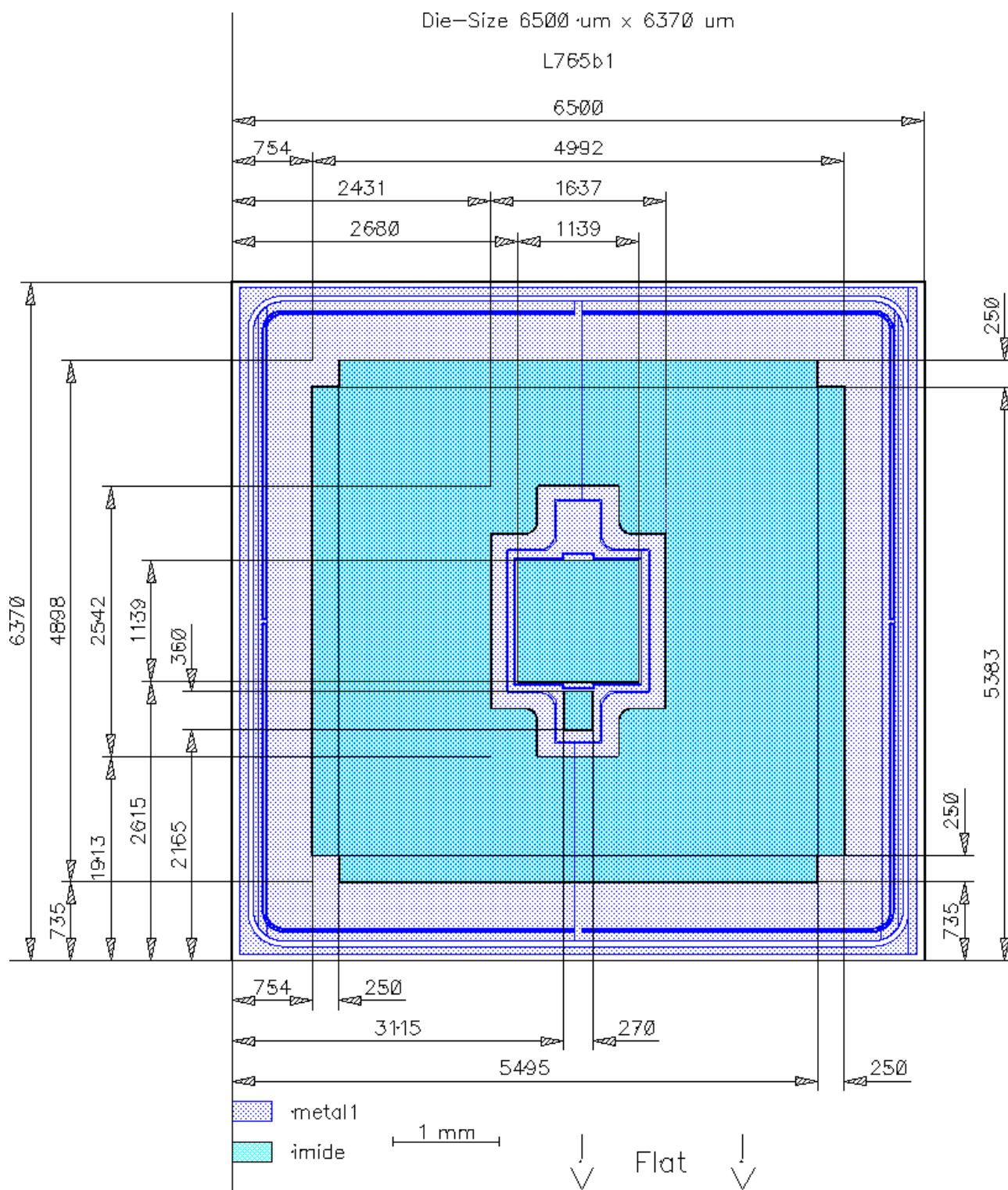
**ELECTRICAL CHARACTERISTICS (tested at component):**

| Parameter                    | Symbol    | Conditions                                | Value |      |      | Unit |
|------------------------------|-----------|-------------------------------------------|-------|------|------|------|
|                              |           |                                           | min.  | typ. | max. |      |
| Input capacitance            | $C_{iss}$ | $V_{CE}=25V,$<br>$V_{GE}=0V,$<br>$f=1MHz$ |       | 2530 |      | pF   |
| Output capacitance           | $C_{oss}$ |                                           |       | 132  |      |      |
| Reverse transfer capacitance | $C_{rss}$ |                                           |       | 115  |      |      |

**SWITCHING CHARACTERISTICS (tested at component), Inductive Load**

| Parameter           | Symbol       | Conditions                                                                                     | Value |      |      | Unit |
|---------------------|--------------|------------------------------------------------------------------------------------------------|-------|------|------|------|
|                     |              |                                                                                                | min.  | typ. | max. |      |
| Turn-on delay time  | $t_{d(on)}$  | $T_j=125^\circ\text{C}$<br>$V_{CC}=600V,$<br>$I_C=35A,$<br>$V_{GE}=-15/15V,$<br>$R_G=27\Omega$ |       | tbd  |      | ns   |
| Rise time           | $t_r$        |                                                                                                |       | tbd  |      |      |
| Turn-off delay time | $t_{d(off)}$ |                                                                                                |       | tbd  |      |      |
| Fall time           | $t_f$        |                                                                                                |       | tbd  |      |      |

## CHIP DRAWING:





Preliminary

# SIGC41T120R3L

## FURTHER ELECTRICAL CHARACTERISTICS:

|                                                      |     |  |
|------------------------------------------------------|-----|--|
| This chip data sheet refers to the device data sheet | tbd |  |
|------------------------------------------------------|-----|--|

## DESCRIPTION:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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